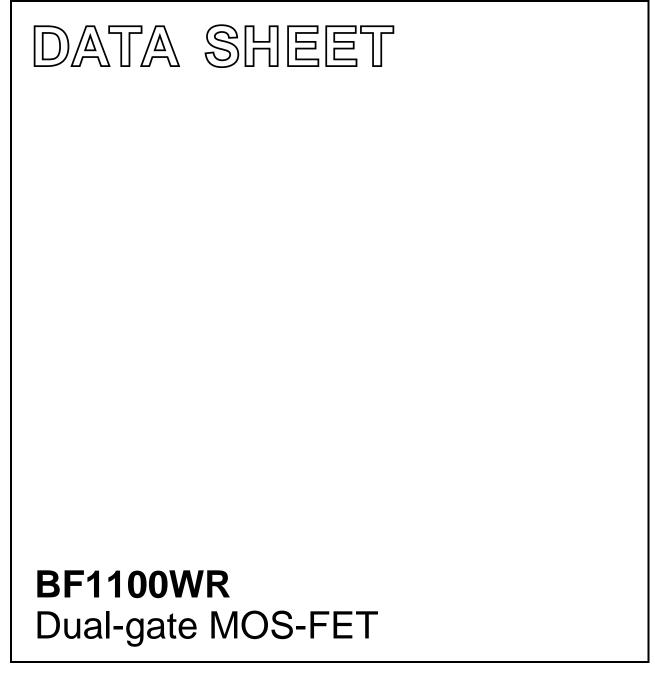
DISCRETE SEMICONDUCTORS



Product specification

1995 Apr 25



BF1100WR

UNIT

FEATURES

- Specially designed for use at 9 to 12 V supply voltage
- Short channel transistor with high forward transfer admittance to input capacitance ratio
- · Low noise gain controlled amplifier up to 1 GHz
- Superior cross-modulation performance during AGC.

APPLICATIONS

• VHF and UHF applications such as television tuners and professional communications equipment.

DESCRIPTION

QUICK REFERENCE DATA

Enhancement type field-effect transistor in a plastic microminiature SOT343R package. The transistor consists of an amplifier MOS-FET with source and substrate interconnected and an internal bias circuit to ensure good cross-modulation performance during AGC.

CAUTION

The device is supplied in an antistatic package. The gate-source input must be protected against static discharge during transport or handling.

sfer

PINNING

PIN	SYMBOL	DESCRIPTION
1	s, b	source
2	d	drain
3	g 2	gate 2
4	9 1	gate 1

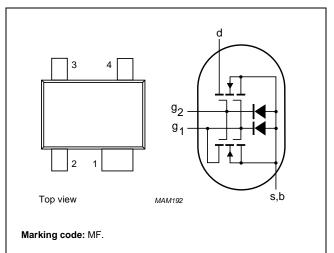


Fig.1 Simplified outline (SOT343R) and symbol.

SYMBOL CONDITIONS PARAMETER MIN. TYP. MAX. V V_{DS} drain-source voltage 14 I_D drain current _ 30 mΑ _ P_{tot} total power dissipation _ _ 280 mW °C Τi operating junction temperature 150 _ _ 24 28 33 |y_{fs}| forward transfer admittance mS 2.2 input capacitance at gate 1 _ 2.6 pF C_{ig1-s} f = 1 MHz25 35 fF C_{rs} reverse transfer capacitance f = 800 MHz F noise figure 2 dB

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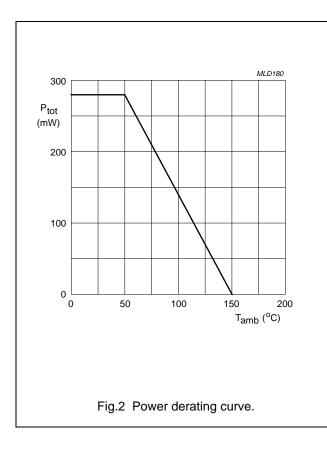
LIMITING VALUES

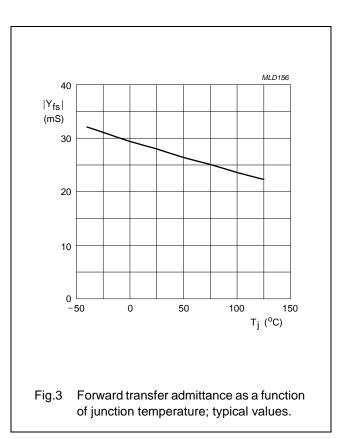
In accordance with the Absolute Maximum Rating System (IEC 134).

SYMBOL	PARAMETER	CONDITIONS	MIN.	MAX.	UNIT
V _{DS}	drain-source voltage		_	14	V
I _D	drain current		_	30	mA
I _{G1}	gate 1 current		-	±10	mA
I _{G2}	gate 2 current		_	±10	mA
P _{tot}	total power dissipation	see Fig.2; up to T_{amb} = 50 °C; note 1	-	280	mW
T _{stg}	storage temperature		-65	+150	°C
Tj	operating junction temperature		_	+150	°C

Note

1. Device mounted on a printed-circuit board.





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THERMAL CHARACTERISTICS

SYMBOL	PARAMETER	CONDITIONS	VALUE	UNIT
R _{th j-a}	thermal resistance from junction to ambient	note 1	350	K/W
R _{th j-s}	thermal resistance from junction to soldering point	T _s = 91 °C; note 2	210	K/W

Notes

- 1. Device mounted on a printed-circuit board.
- 2. $\ensuremath{\mathsf{T}_{\mathsf{s}}}$ is the temperature at the soldering point of the source lead.

STATIC CHARACTERISTICS

 $T_j = 25 \ ^{\circ}C$; unless otherwise specified.

SYMBOL	PARAMETER	CONDITIONS	MIN.	MAX.	UNIT
V _{(BR)G1-SS}	gate 1-source breakdown voltage	$V_{G2-S} = V_{DS} = 0; I_{G1-S} = 1 \text{ mA}$	13.2	20	V
V _{(BR)G2-SS}	gate 2-source breakdown voltage	$V_{G1-S} = V_{DS} = 0; I_{G2-S} = 1 \text{ mA}$	13.2	20	V
V _{(F)S-G1}	forward source-gate 1 voltage	$V_{G2-S} = V_{DS} = 0; I_{S-G1} = 10 \text{ mA}$	0.5	1.5	V
V _{(F)S-G2}	forward source-gate 2 voltage	$V_{G1-S} = V_{DS} = 0; I_{S-G2} = 10 \text{ mA}$	0.5	1.5	V
V _{G1-S(th)}	gate 1-source threshold voltage	$V_{G2-S} = 4 V; V_{DS} = 9 V;$ $I_D = 20 \ \mu A$	0.3	1	V
		$V_{G2-S} = 4 V; V_{DS} = 12 V;$ $I_D = 20 \ \mu A$	0.3	1	V
V _{G2-S(th)}	gate 2-source threshold voltage	$V_{G1-S} = 4 V; V_{DS} = 9 V;$ $I_D = 20 \ \mu A$	0.3	1.2	V
		$V_{G1-S} = 4 V; V_{DS} = 12 V;$ $I_D = 20 \ \mu A$	0.3	1.2	V
I _{DSX}	drain-source current	$V_{G2-S} = 4 V; V_{DS} = 9 V;$ R _{G1} = 180 kΩ; note 1	8	13	mA
		V_{G2-S} = 4 V; V_{DS} = 12 V; R _{G1} = 250 kΩ; note 2	8	13	mA
I _{G1-SS}	gate 1 cut-off current	$V_{G2-S} = V_{DS} = 0; V_{G1-S} = 12 V$	-	50	nA
I _{G2-SS}	gate 2 cut-off current	$V_{G1-S} = V_{DS} = 0; V_{G2-S} = 12 V$	-	50	nA

Notes

1. R_{G1} connects gate 1 to V_{GG} = 9 V; see Fig.26.

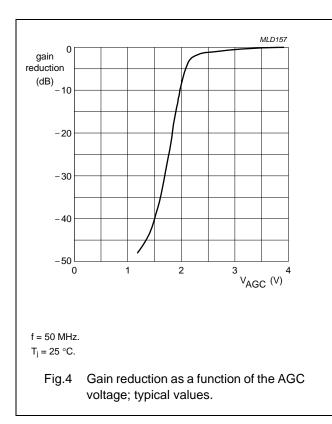
2. R_{G1} connects gate 1 to V_{GG} = 12 V; see Fig.26.

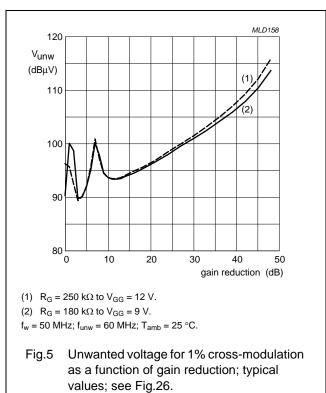
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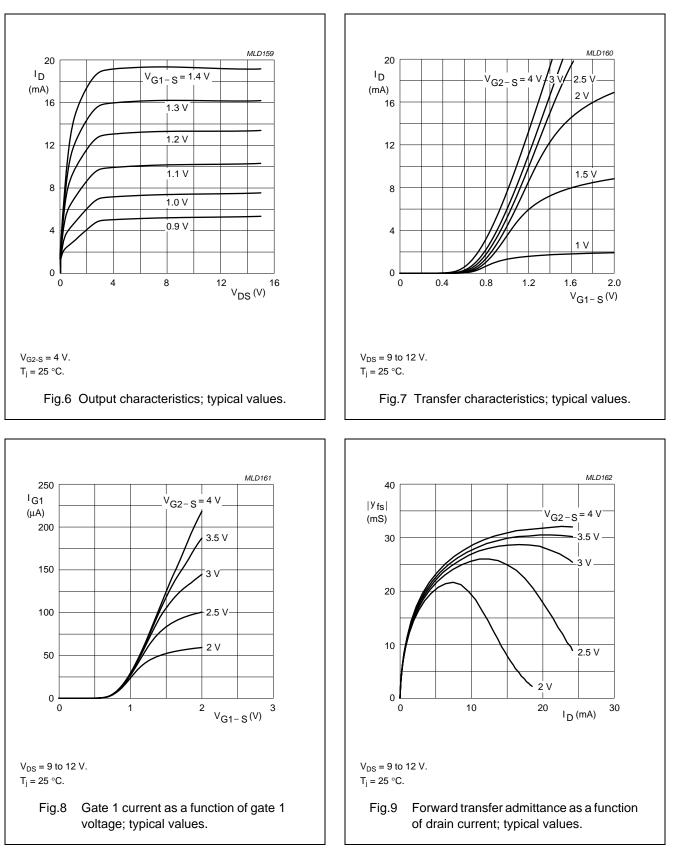
DYNAMIC CHARACTERISTICS

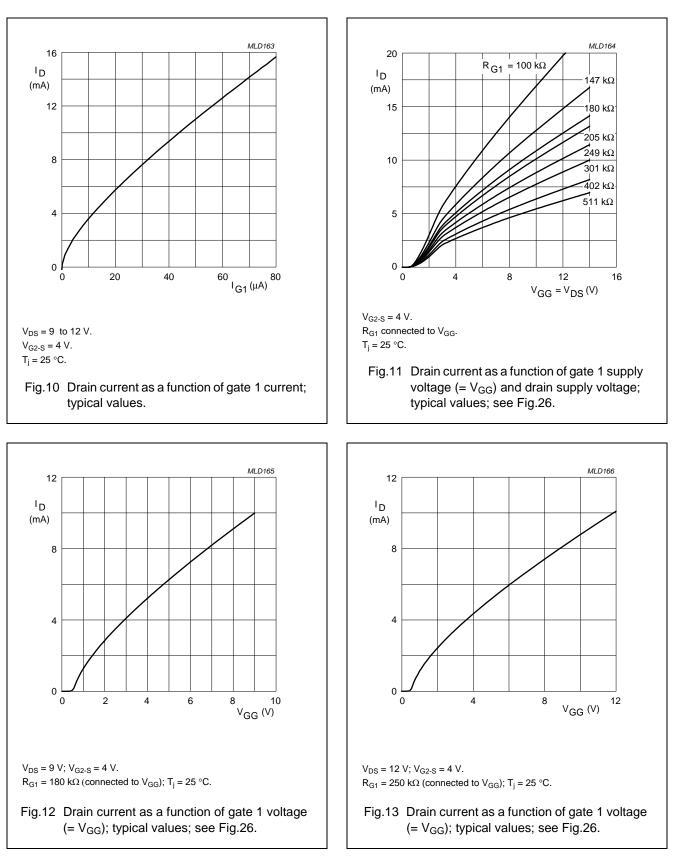
Common source; $T_{amb} = 25 \text{ °C}$; $V_{G2-S} = 4 \text{ V}$; $I_D = 10 \text{ mA}$; unless otherwise specified.

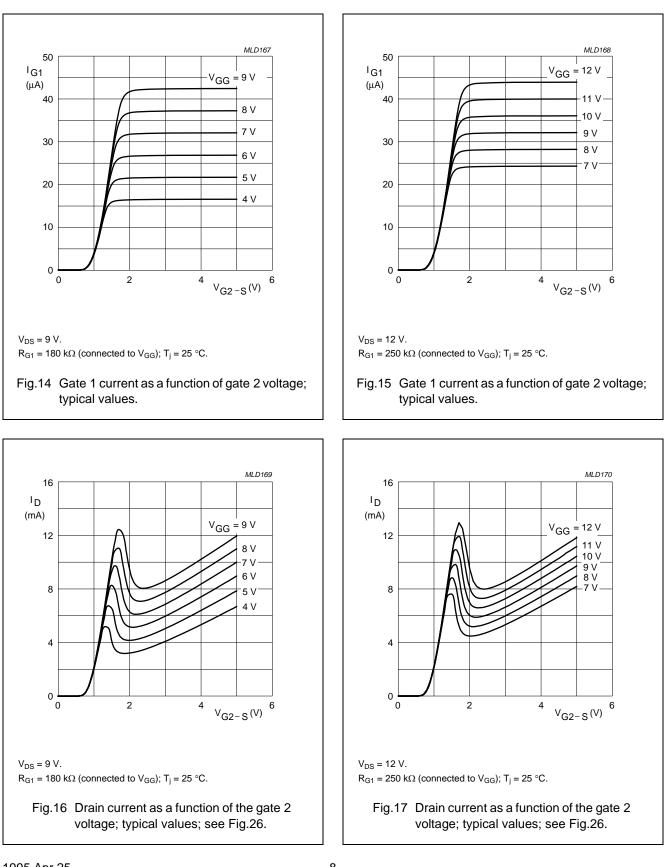
SYMBOL	PARAMETER	CONDITIONS	MIN.	TYP.	MAX.	UNIT
y _{fs}	forward transfer admittance	pulsed; T _j = 25 °C				
		$V_{DS} = 9 V$	24	28	33	mS
		V _{DS} = 12 V	24	28	33	mS
C _{ig1-s}	input capacitance at gate 1	f = 1 MHz				
		$V_{DS} = 9 V$	-	2.2	2.6	pF
		V _{DS} = 12 V	-	2.2	2.6	pF
C _{ig2-s}	input capacitance at gate 2	f = 1 MHz				
		V _{DS} = 9 V	-	1.6	-	pF
		V _{DS} = 12 V	-	1.4	-	pF
C _{os}	drain-source capacitance	f = 1 MHz				
		V _{DS} = 9 V	-	1.4	1.8	pF
		V _{DS} = 12 V	-	1.1	1.5	pF
C _{rs}	reverse transfer capacitance	f = 1 MHz				
		V _{DS} = 9 V	-	25	35	fF
		V _{DS} = 12 V	-	25	35	fF
F	noise figure	$f = 800 \text{ MHz}; G_S = G_{Sopt}; B_S = B_{Sopt}$				
		V _{DS} = 9 V	-	2	2.8	dB
		V _{DS} = 12 V	_	2	2.8	dB

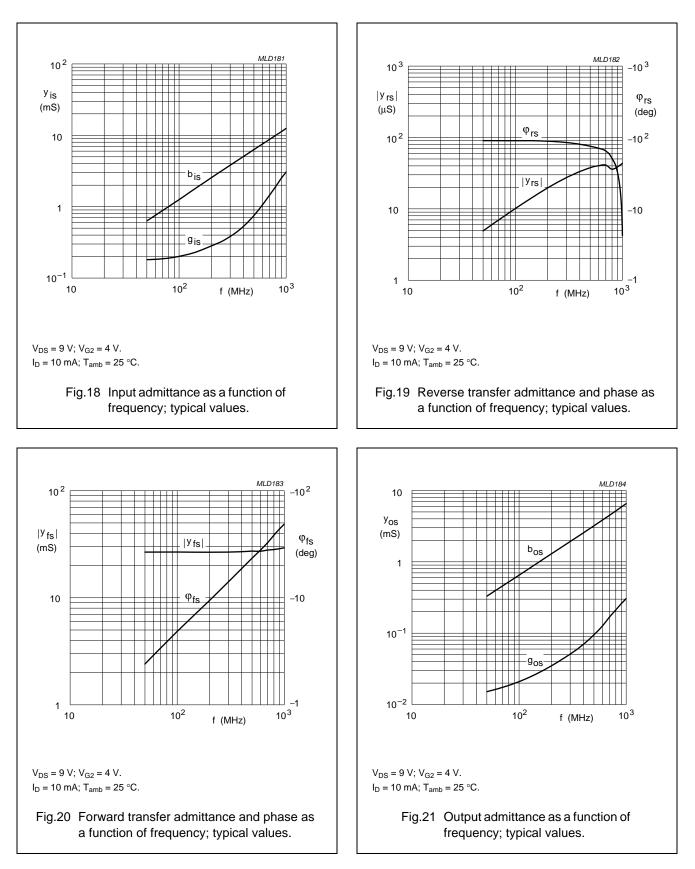


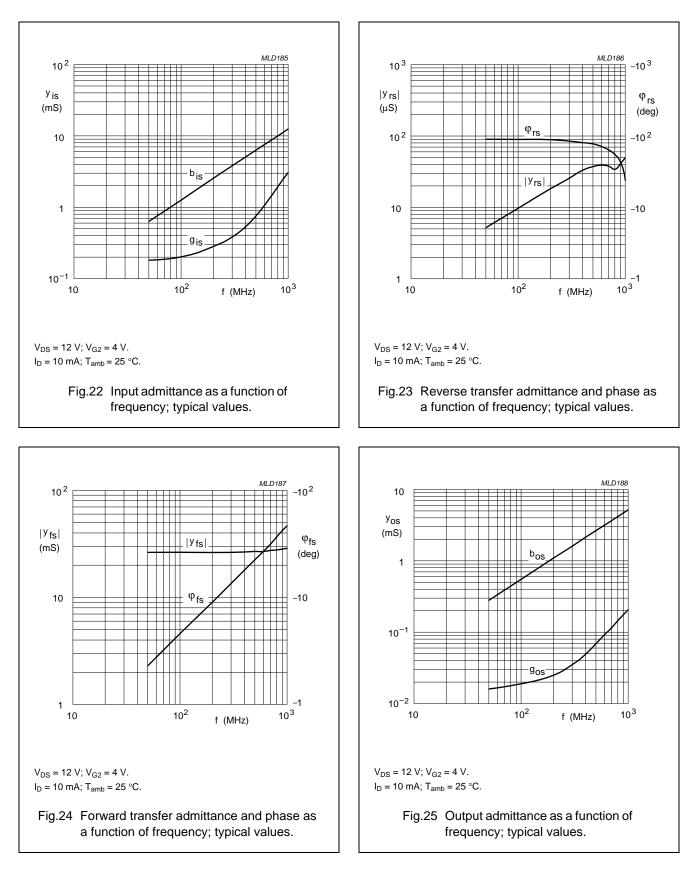


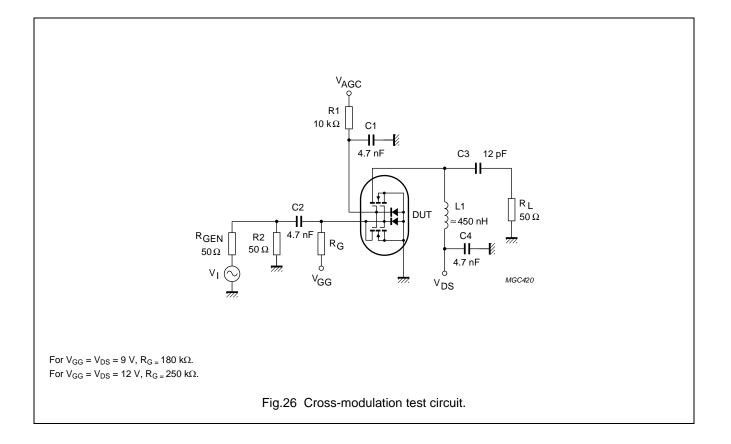












BF1100WR

Dual-gate MOS-FET

	s ₁₁		S21	s ₂₁		s ₁₂		\$ ₂₂	
f (MHz)	MAGNITUDE (ratio)	ANGLE (deg)	MAGNITUDE (ratio)	ANGLE (deg)	MAGNITUDE (ratio)	ANGLE (deg)	MAGNITUDE (ratio)	ANGLE (deg)	
50	0.985	-3.9	2.618	175.1	0.001	137.9	1.000	-1.9	
100	0.981	-7.3	2.602	170.5	0.001	80.4	0.999	-4.0	
200	0.975	-14.4	2.577	160.7	0.002	74.0	0.995	-7.6	
300	0.965	-21.6	2.555	151.6	0.002	79.3	0.994	-11.3	
400	0.947	-28.3	2.513	141.8	0.003	80.5	0.992	-15.0	
500	0.927	-34.9	2.449	133.4	0.003	82.8	0.988	-18.5	
600	0.913	-41.7	2.339	124.6	0.003	78.9	0.984	-22.0	
700	0.890	-47.9	2.361	115.4	0.003	80.6	0.982	-25.3	
800	0.869	-54.0	2.302	106.4	0.003	93.9	0.979	-28.8	
900	0.845	-59.7	2.228	97.6	0.003	104.8	0.976	-32.1	
1000	0.823	-65.4	2.167	89.6	0.003	129.3	0.974	-35.5	

Table 1 Scattering parameters: V_{DS} = 9 V; V_{G2-S} = 4 V; I_D = 10 mA

Table 2 Noise data: V_{DS} = 9 V; V_{G2-S} = 4 V; I_D = 10 mA

f	F _{min} Γ_{opt}		-	
(MHz)	(dB)	(ratio)	(deg)	'n
800	2.00	0.67	43.9	0.89

Table 3 Scattering parameters: V_{DS} = 12 V; V_{G2-S} = 4 V; I_D = 10 mA

f	S ₁₁		S ₂₁	s ₂₁		S ₁₂		S ₂₂	
ı (MHz)	MAGNITUDE (ratio)	ANGLE (deg)	MAGNITUDE (ratio)	ANGLE (deg)	MAGNITUDE (ratio)	ANGLE (deg)	MAGNITUDE (ratio)	ANGLE (deg)	
50	0.985	-3.7	2.576	175.3	0.000	125.0	1.000	-1.6	
100	0.980	-7.4	2.563	170.9	0.001	111.2	1.000	-3.3	
200	0.973	-14.6	2.541	161.6	0.002	83.0	0.997	-6.4	
300	0.962	-21.5	2.519	152.9	0.002	85.2	0.996	-9.3	
400	0.946	-28.5	2.479	143.5	0.003	79.4	0.995	-12.4	
500	0.929	-35.0	2.419	135.5	0.003	78.2	0.991	-15.3	
600	0.912	-41.6	2.373	127.2	0.003	80.0	0.989	-18.1	
700	0.895	-47.8	2.336	118.7	0.003	83.4	0.987	-20.9	
800	0.868	-53.8	2.284	110.0	0.003	91.3	0.985	-23.7	
900	0.845	-59.8	2.213	101.6	0.003	95.9	0.983	-26.5	
1000	0.823	-65.7	2.160	94.1	0.003	112.2	0.981	-29.3	

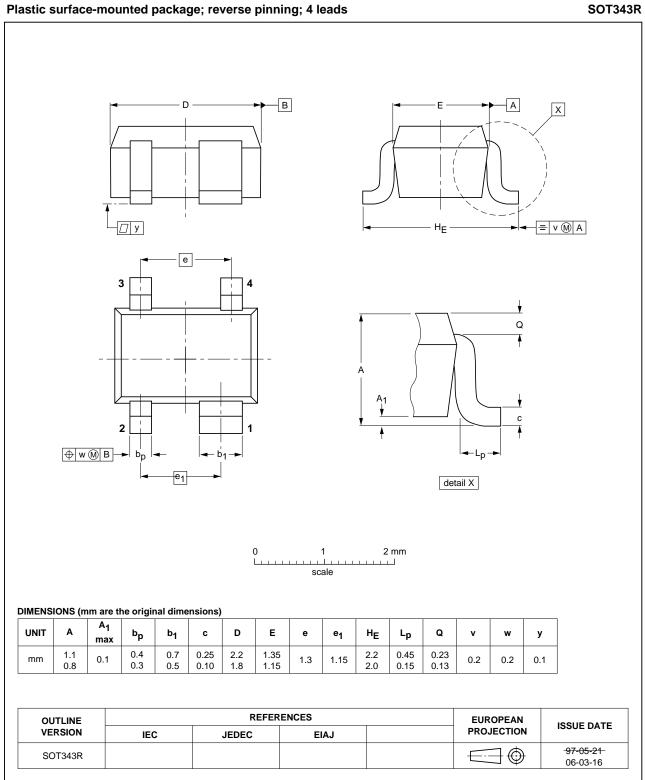
Table 4 Noise data: V_{DS} = 12 V; V_{G2-S} = 4 V; I_D = 10 mA

f	f F _{min} Γ _{opt}		-	
(MHz)	(dB)	(ratio)	(deg)	'n
800	2.00	0.66	43.3	0.97

BF1100WR

Dual-gate MOS-FET

PACKAGE OUTLINE



BF1100WR

DATA SHEET S	TATUS
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DOCUMENT STATUS ⁽¹⁾	PRODUCT STATUS ⁽²⁾	DEFINITION
Objective data sheet	Development	This document contains data from the objective specification for product development.
Preliminary data sheet	Qualification	This document contains data from the preliminary specification.
Product data sheet	Production	This document contains the product specification.

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Dual-gate MOS-FET

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